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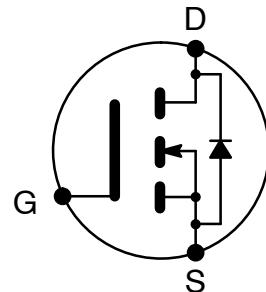
**NTE2382**  
**MOSFET**  
**N-Channel Enhancement Mode,**  
**High Speed Switch**  
**(Compl to NTE2383)**

**Description:**

The NTE2382 is a MOS power N-Channel FET in a TO220 type package designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid, and relay drivers.

**Features:**

- Lower  $R_{DS(ON)}$
- Improved Inductive Ruggedness
- Fast Switching Times
- Rugged Polysilicon Gate Cell Structure
- Lower Input Capacitance
- Extended Safe Operating Area
- Improved High Temperature Reliability



**Absolute Maximum Ratings:**

Drain-Source Voltage (Note 1), $V_{DSS}$ .....	100V
Drain-Gate Voltage ( $R_{GS} = 1M\pm$ , Note 1), $V_{DGR}$ .....	100V
Gate-Source Voltage, $V_{GS}$ .....	$\pm 20V$
Continuous Drain Current, $I_D$	
$T_C = +25^\circ C$ .....	9.2A
$T_C = +100^\circ C$ .....	6.5A
Drain Current, Pulsed (Note 3), $I_{DM}$ .....	37A
Gate Current, Pulsed, $I_{GM}$ .....	$\pm 1.5A$
Single Pulsed Avalanche Energy (Note 4), $E_{AS}$ .....	36mJ
Avalanche Current, $I_{AS}$ .....	9.2A
Total Power Dissipation ( $T_C = +25^\circ C$ ), $P_D$ .....	50W
Derate Above $25^\circ C$ .....	0.4W/ $^\circ C$
Operating Junction Temperature Range, $T_{opr}$ .....	-55° to +150° $^\circ C$
Storage Temperature Range, $T_{stg}$ .....	-55° to +150° $^\circ C$
Thermal Resistance, Junction-to-Ambient, $R_{thJA}$ .....	62.5° $^\circ C/W$
Thermal Resistance, Junction-to-Case, $R_{thJC}$ .....	2.5° $^\circ C/W$
Thermal Resistance, Case-to-Sink (Note 5), $R_{thCS}$ .....	0.5° $^\circ C/W$
Maximum Lead Temperature (During Soldering, 1/8" from case, 5sec), $T_L$ .....	+300° $^\circ C$

Note 1.  $T_J = +25^\circ$  to  $+150^\circ C$

Note 2. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .

Note 3. Repetitive rating: Pulse width limited by max. junction temperature.

Note 4. L = 64mH, V<sub>DD</sub> = 25V, R<sub>G</sub> = 25±, Starting T<sub>J</sub> = +25°C.

Note 5. Mounting surface flat, smooth, and greased.

**Electrical Characteristics:** (T<sub>C</sub> = +25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain–Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 0.25mA	100	—	—	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0	—	—	0.25	mA
		V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0, T <sub>J</sub> = +125°C	—	—	1.0	mA
Gate–Body Leakage Current, Forward	I <sub>GSS</sub>	V <sub>GS</sub> = 20V	—	—	100	nA
Gate–Body Leakage Current, Reverse	I <sub>GSS</sub>	V <sub>GS</sub> = 20V	—	—	-100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.25mA	2.0	—	4.0	V
Static Drain–Source On–Resistance	r <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.6A, Note 2	—	—	0.27	±
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> ≥ 50V, I <sub>D</sub> = 4.6A, Note 2	2.7	4.1	—	mhos
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0, f = 1MHz	—	400	—	pF
Output Capacitance	C <sub>oss</sub>		—	130	—	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		—	40	—	pF
Turn–On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 50V, I <sub>D</sub> = 9.2A, Z <sub>O</sub> = 18±, MOSFET switching times are essentially independent of operating temperature	—	8.8	13.0	ns
Rise Time	t <sub>r</sub>		—	30	45	ns
Turn–Off Delay Time	t <sub>d(off)</sub>		—	19	27	ns
Fall Time	t <sub>f</sub>		—	20	30	ns
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 80V, I <sub>D</sub> = 9.2A, Gate charge is essentially independent of operating temperature	—	—	23	nC
Gate–Source Charge	Q <sub>gs</sub>		—	4.6	—	nC
Gate–Drain (“Miller”) Charge	Q <sub>gd</sub>		—	9.1	—	ns
<b>Source–Drain Diode Ratings and Characteristics</b>						
Continuous Source Current (Body Diode)	I <sub>S</sub>		—	—	9.2	A
Pulse Source Current (Body Diode)	I <sub>SM</sub>	Note 3	—	—	37	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = +25°C, I <sub>S</sub> = 9.2A, V <sub>GS</sub> = 0V, Note 2	—	—	2.5	V
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = +25°C, I <sub>F</sub> = 9.2A, dI <sub>F</sub> /dt = 100A/≥s	—	110	240	ns

Note 2. Pulse Test: Pulse Width ≤ 300≥s, Duty Cycle ≤ 2%.

Note 3. Repetitive rating: Pulse width limited by max. junction temperature.

